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| <b>Search Notes</b><br><br> | <b>Application/Control No.</b><br><br>10798994 | <b>Applicant(s)/Patent Under Reexamination</b><br><br>BECK ET AL. |
|  | <b>Examiner</b><br><br>LUONG T NGUYEN          | <b>Art Unit</b><br><br>2622                                       |

| SEARCHED |          |      |          |
|----------|----------|------|----------|
| Class    | Subclass | Date | Examiner |
|          |          |      |          |

| SEARCH NOTES  |         |          |
|---|---------|----------|
| Search Notes  | Date    | Examiner |
| updated East using previously cited references                | 3/13/08 | LTN      |
| updated East using previously cited references                | 9/14/08 | LTN      |
| EAST (USPAT; USPGPUB; JPO; EPO; DERWENT; IBM_TDB) text search | 2/25/09 | LTN      |

| INTERFERENCE SEARCH |          |      |          |
|---------------------|----------|------|----------|
| Class               | Subclass | Date | Examiner |
|                     |          |      |          |

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